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### **EH25 Series Oscillator**

Quartz Crystal Clock Oscillators XO (SPXO) HCMOS/TTL (CMOS) 5.0Vdc 4 Pad 5.0mm x 7.0mm Ceramic Surface Mount (SMD)

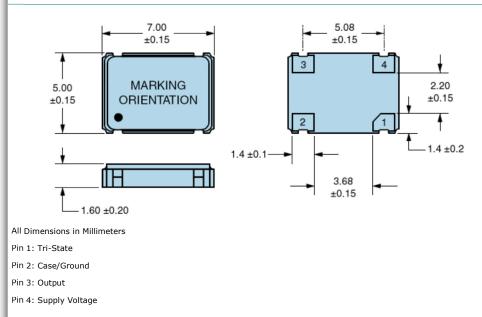
	Lead Free China RoHS EU RoHS REACH 2011/65 + 2015/863 168 SVHC
lectrical Specifications	COMPLIANT COMPLIANT COMPLIANT Revision G 06/08/2012
Nominal Frequency	1.000MHz to 155.520MHz Some frequencies within this range may not be available.
Frequency Tolerance/Stability	(Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) ±100ppm Maximum ±50ppm Maximum ±25ppm Maximum ±20ppm Maximum
Aging at 25°C	±5ppm/year Maximum
Operating Temperature Range	0°C to +70°C -40°C to +85°C
Supply Voltage	5.0V <sub>DC</sub> ±10%
Input Current	No Load 50mA Maximum
Output Voltage Logic High (V <sub>OH</sub> )	$\rm I_{OH}\text{=}$ -16mA 2.4V_{DC} Minimum with TTL Load, V_{DD}\text{-}0.4V_{DC} Minimum with HCMOS Load
Output Voltage Logic Low (V <sub>OL</sub> )	$I_{\mbox{\scriptsize OL}}$ = +16mA 0.4V_{\mbox{\scriptsize DC}} Maximum with HCMOS Load
Duty Cycle	50 $\pm$ 10(%) Measured at 1.4V <sub>DC</sub> with TTL Load or at 50% of waveform with HCMOS Load from 1MHz to 70MHz Measured at 50% of waveform above 70MHz 50 $\pm$ 5(%) Measured at 50% of waveform
Rise Time/Fall Time	Measured at 0.8V <sub>DC</sub> to 2.0V <sub>DC</sub> with TTL Load; Masured at 20% to 80% of waveform with HCMOS Load 6nSec Maximum from 1MHz to 70MHz 4nSec Maximum from 70.000001MHz to 155.520MHz
Load Drive Capability	10 TTL Load or 50pF HCMOS Load Maximum from 1MHz to 70MHz 5 TTL Load or 15pF HCMOS Load Maximum from 70.000001MHz to 155.520MHz
Output Logic Type	CMOS
Pin 1 Connection	Tri-State (High Impedance)
Tri-State Input Voltage (Vih and Vil)	$+2.2V_{DC}$ Minimum to Enable Output, $+0.8V_{DC}$ Maximum to Disable Output (High Impedance), No Connect to Enable Output
Absolute Clock Jitter	±250pSec Maximum, ±100pSec Typical
One Sigma Clock Period Jitter	±50pSec Maximum, ±30pSec Typical

Start Up Time

Storage Temperature

10mSec Maximum -55°C to +125°C

### **Mechanical Dimensions**

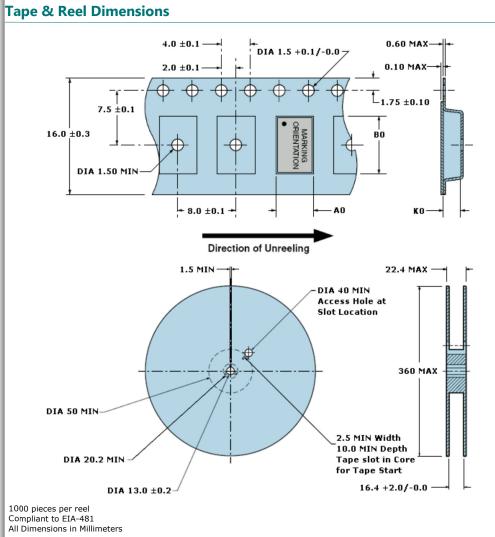


## **Marking Specifications**

Line 1:	ECLIPTEK
Line 2:	<ul> <li>XXXXXXM</li> <li>XXXXXX = Nominal Frequency (5 Digits + Decimal)</li> <li>M = Frequency unit of measure (MHz)</li> </ul>
Line 3:	XXXXX • XXXXX = Ecliptek Manufacturing Identifier

# Environmental and Mechanical Specifications

ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM:1500V
Fine Leak Test	MIL-STD-883, Method 1014, Condition A
Flammability	UL94-V0
Gross Leak Test	MIL-STD-883, Method 1014, Condition C
Mechanical Shock	MIL-STD-883, Method 2002, Condition B
Moisture Resistance	MIL-STD-883, Method 1004
Moisture Sensitivity	J-STD-020, MSL 1
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K
Resistance to Solvents	MIL-STD-202, Method 215
Solderability	MIL-STD-883, Method 2003
Temperature Cycling	MIL-STD-883, Method 1010, Condition B
Vibration	MIL-STD-883, Method 2007, Condition A
Thermal Resistance ( $\theta_{JA}$ )	42°C/W (degrees Celsius per Watt)
Thermal Resistance ( $\theta_{JC}$ )	15°C/W (degrees Celsius per Watt)



#### **Test Circuit for TTL Output** R<sub>L</sub> Value (Ohms) C<sub>L</sub> Value (pF) Output Load Drive Capabilit 390 15 5TTL 780 15 Frequency Counter 1100 Oscillos 2TTL 6 15 10LSTTL 2000 1TTL 2200 3 Table 1: R<sub>L</sub> Resistance Value and C<sub>L</sub> Capacitance Value Vs. Output Load Drive Capability Probe Supply Voltage (Note 2) Note 4) (V<sub>DD</sub>) Output Current Meter 0 $\cap$ + Power Supply 0.01µF 0.1µF (Note 1) Voltage C<sub>L</sub> (Note 3) Me (Note 1) Ground $\cap$ No Connect 9 or Tri-State

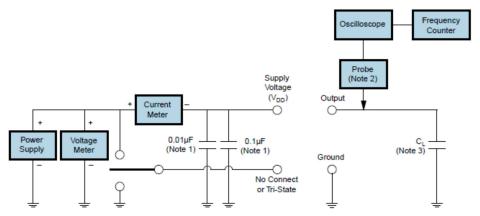
**Note 1:** An external  $0.1\mu$ F low frequency tantalum bypass capacitor in parallel with a  $0.01\mu$ F high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attentuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

**Note 3:** Capacitance value C<sub>L</sub> includes sum of all probe and fixture capacitance.

**Note 4:** Resistance value  $R_L$  is shown in Table 1. See applicable specification sheet for  $\hat{a} \in \text{Load Drive Capability} \hat{a} \in \mathbb{N}$ . **Note 5:** All diodes are MMBD7000, MMBD914, or equivalent.

### **Test Circuit for CMOS Output**

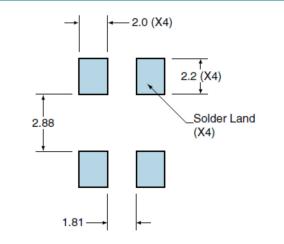


Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attentuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

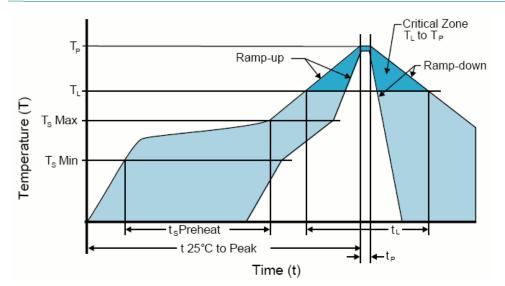
Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

### **Recommended Solder Pad Dimensions**



Tolerances = ±0.1 All Dimensions in Millimeters

### **Solder Reflow Profile**



#### High Temperature Infrared/Convection

Note: Temperatures shown are applied to body of device.

T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	3°C/Second Maximum
Preheat	
- Temperature Minimum (T <sub>S</sub> MIN)	150°C
- Temperature Typical (T <sub>S</sub> TYP)	175°C
- Temperature Maximum (T <sub>S</sub> MAX)	200°C
- Time (t <sub>S</sub> )	60 - 180 Seconds
Ramp-up Rate ( $T_L$ to $T_P$ )	3°C/Second Maximum
Time Maintained Above:	
- Temperature (T <sub>L</sub> )	217°C
- Time (t <sub>L</sub> )	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (Tp Target)	250°C +0/-5°C
Time within $5^{\circ}$ C of actual peak (t <sub>P</sub> )	20 - 40 Seconds
Ramp-down Rate	6°C/Second Maximum
Time 25°C to Peak Temperature (t)	8 Minutes Maximum
Moisture Sensitivity Level	Level 1

#### Low Temperature Infrared/Convection

<b>Note:</b> Temperatures shown are applied to body of device.	
T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/Second Maximum
Preheat	
- Temperature Minimum (T <sub>S</sub> MIN)	N/A
- Temperature Typical (T <sub>S</sub> TYP)	150°C
- Temperature Maximum (T <sub>S</sub> MAX)	N/A
- Time (t <sub>S</sub> )	60 - 120 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/Second Maximum
Time Maintained Above:	
- Temperature (T <sub>L</sub> )	150°C
- Time (t <sub>L</sub> )	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	240°C Maximum
Target Peak Temperature (Tp Target)	240°C Maximum 2 Times / 230°C Maximum 1 Time
Time within $5^{\circ}$ C of actual peak (t <sub>P</sub> )	10 Seconds Maximum 2 Times / 80 Seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

#### High Temperature Manual Soldering

Note: Temperatures listed are applied to body of device. 260°C Maximum for 5 Seconds Maximum, 2 times Maximum.

#### Low Temperature Manual Soldering

Note: Temperatures listed are applied to body of device. 185°C Maximum for 10 Seconds Maximum, 2 times Maximum.

### 1 - Build A Part Number

Select the parameters that meet your requirements and then  $\operatorname{click}\nolimits\mathsf{Next}$ 

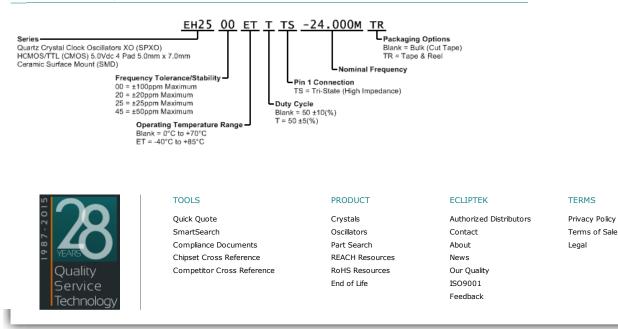


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### **Part Numbering Guide**



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